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Electronic structure of hydrothermally synthesized single crystal $U_{0.22}Th_{0.78}O_2$

D. B. Turner*, T. D. Kelly, G. R. Peterson, J. D. Reding, R. L. Hengehold, J. M. Mann, J. W. Kolis, X. Zhang, P. A. Dowben, and J. C. Petrosky*,

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Single crystals of ThO₂, UO₂, and their solid solutions, $U_x Th_{1-x}O_2$, have been obtained through various hydrothermal growth conditions. This technique offers the better of two other growth processes: (i) single crystal purity as by photochemical growth of nanocrystals; and (ii) large/bulk sizes as obtained by the arc melt method. The band gap of the $U_x Th_{1-x}O_2$ single crystal solid solution, along with the luminescence transition, have been characterized. The occupied and unoccupied structures are determined using ultraviolet and inverse photoemission spectroscopy and the electronic band gap was measured to be 3–4 eV. The strain of

incorporating U into the ThO_2 is analyzed through Vegard's law. In this crystal there are defect and impurity sites, likely arising from the kinetic growth process, giving rise to a similar yet slightly different optical gap evident with cathodoluminescence spectroscopy. There is a major luminescence feature spanning the range from 3.18 to $4.96\,\mathrm{eV}$ (250–390 nm) with a maximum at $4.09\,\mathrm{eV}$ (303 nm), corresponding with the measured electronic band gap. In this paper, the electronic properties of a solid solution $U_{0.22}Th_{0.78}O_2$ are measured and interpreted compared to the pure actinide oxides, ThO_2 and UO_2 .

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1 Introduction The next generation of nuclear power reactors will realize advances in fuel burn efficiency, environmental protection, and non-proliferation factors, culminating in the Generation-IV reactor classification. While many Generation-IV designs are being considered, most, if not all, have a closed fuel cycle to improve non-proliferation. Central to the issue of a closed fuel cycle are not only the obvious improvements in structural materials to withstand high pressures, temperatures, and chemical corrosion, but also advancements and improvements to useable nuclear fuels. Most of the world's current nuclear fuel technology consists of uranium dioxide and mixed uranium—plutonium oxide fuels. However, Generation-IV reactors require novel nuclear fuels to be developed, therefore, new alloys of oxides [1–3], carbides [4–7], and

nitrides [8] are being considered. In particular, these fuel technologies are being studied down to the micrometer scale or smaller, where defects result in drastic changes in material characteristics, such as thermal and electronic performance or defect formation, clustering, and impurity migration under radiation.

Already, uranium—thorium dioxide alloys $(U_x Th_{1-x} O_2)$ are of particular global interest as nuclear fuels due to their potential benefits in nuclear power and nuclear waste storage [9, 10] through the thorium fuel cycle. However, for their use in Generation-IV reactors, mixed oxide fuels may additionally exhibit beneficial physical and electronic properties that extend their usefulness beyond traditional nuclear fuel applications into regions such as nuclear detection, remote fuel burn up monitoring, and

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radiation-hardened electronics by design. For example, initial theoretical results conclude that well-ordered mixed oxide fuels have reduced defect migration as in the case of the formation and mobility of He²⁺ ions [11, 12] and Xe (as a representative fission gas) [13]. Furthermore, experimental studies of colloids and ceramics indicate that the physical and electronic properties are variable (tunable) being extremely sensitive to material type and quality [14–20].

While ThO₂ and UO₂ single crystals have been previously synthesized [2, 3, 9, 21–33], the growth techniques did not provide the necessarily high quality combined with an appropriately "large" (ex. several millimeters) size suitable for spectroscopic analysis and device development while retaining a single crystal structure. For example, it has recently been demonstrated that nanocrystals of UO₂, ThO₂, and their solid solutions may be synthesized through low temperature (575–725 K) photochemical processes [3, 9, 21]. However, the crystal sizes are unsuitable for comparative studies of much larger, bulk mixed oxide fuels. On the other hand, larger single crystals of UO₂ have been synthesized through the traditional arc melt method [19, 20]. However this growth process results in crystals with thermal strain, high defect densities, and only short range order while allowing very little control in how these defects form and distribute themselves. From a review of these two growth processes, it is determined that temperature, pressure, and environmental conditions need to be precisely controlled in order to obtain large, single crystals of ThO₂, UO₂, and their solid solutions with well-resolved stoichiometry and limited defect density.

In the present research, a hydrothermal synthesis technique was developed [34, 35] and demonstrated to be suitable for quality ThO₂ crystal growth. This was followed by the synthesis and structural confirmation of $U_rTh_{1-r}O_2$ single crystal alloys [36]. While the ThO₂ single crystal band structure has been studied [37, 38], to our knowledge, the $U_x Th_{1-x}O_2$ has not been extensively studied beyond colloids, theoretical calculations, or cursory diffraction measurements [36]. Of particular interest is the role of the U 5f band when included into the ThO₂ matrix. Since ThO₂ is an n-type insulator with a band gap of 6-7 eV [38], and UO₂ is a large band gap semiconductor with its carrier type depending on temperature with localized f-electrons, it is desirable to determine how forming a solid solution of U within a ThO₂ matrix alters the resistive properties of the ThO₂ structure. The nature of the UO₂ 5f electronic state's interactions with the ThO₂ matrix may be illuminated through a combination of traditional photoemission techniques [38, 39] combined with luminescence measurements. In this research, the fundamental band gap of a $U_x Th_{1-x}O_2$ single crystal solid solution is measured with ultraviolet and inverse photoemission spectroscopy. Then, the optical band gap and luminescence transitions are analyzed using cathodoluminescence spectroscopy. The results are important for establishing fundamental properties of single crystal $U_x Th_{1-x} O_2$ alloys that may then have their structural, thermal, and electronic properties tuned in order to understand their characteristics within extreme environments such as in next generation nuclear reactors.

2 Experimental

2.1 Crystal arowth and preparation The U_{0.22}Th_{0.78}O₂ single crystal studied in this research was hydrothermally synthesized kinetically in a supercritical 9 M CsF mineralizer as detailed elsewhere [36]. The structure of U_{0.22}Th_{0.78}O₂ was confirmed as a fluorite crystal lattice through X-ray diffraction as previously for other refractory oxides grown through by this method, such as ThO₂ [34, 37] and HfO₂ [35]. The previous studies of ThO₂ obtained through this technique indicated that the surface can have near surface regions of impurity deposits resulting from cooling the hydrothermal solution. In order to remove these crystallite surface cations and anions resulting from the growth technique, an etching process was developed by our research group consisting of an organic solution of mixed crown ethers (15-crown-5, [C₂H₄O]₅ and 18-crown-6, $[C_2H_4O]_6$) and picric acid $(C_6H_3N_3O_7)$. A 30 mM dichloromethane solution of crown ethers (1:1 molar ratio of $[C_2H_4O]_5$ and $[C_2H_4O]_6$) and a 22.6 mM $C_6H_3N_3O_7(aq)$ solution was mixed with the crystal using a magnetic stir bar for 24 h which removed approximately 100 nm of the surface. Following this chemical etch, the crystal was baked in a vacuum desiccator for 16 h at 180 °C to limit hydration before subsequent measurements. The successfulness of the chemical etching was validated and confirmed by X-ray fluorescence spectroscopy using a Horiba XGT-7000 micro-XRF using a liquid nitrogen cooled Si(Li) detector.

2.2 Photoemission instrumentation Ultraviolet photoemission spectroscopy (UPS) and inverse photoemission spectroscopy (IPES) experiments were measured under ultrahigh vacuum conditions ($\sim 10^{-10}$ Torr). The UPS spectra were acquired with a SPECS PHOIBOS 150 CCD electron energy analyzer having an energy resolution of $\sim 30 \,\mathrm{meV}$ at room temperature when using the He(I) 21.2 eV emission line. While using the Omicron DAR 400 X-ray source, both the X-ray gun and sample were grounded to minimize sample surface charging effects, although surface charging may still have occurred without the use of a flood gun. The IPES measurements were obtained using a Kimball Physics ELG-2A-6299 electron gun and an OmniVac IPES 1000 solid state detector. In order to prevent system contamination from sputter etching the surface, the reported spectra are of "as grown" samples. Both UPS and IPES spectra have been aligned to the Fermi level, and binding energy spectra are plotted as $E-E_F$ as previously for other materials such as ThO₂ [38], UO₂ [39], MoS₂:Na [40], and EuO:Gd [41].

2.3 Cathodoluminescent instrumentation The cathodoluminescence spectroscopy (CL) was measured under ultrahigh vacuum (1×10^{-8} Torr). The $U_{0.22}Th_{0.78}O_2$ sample was adhered to a Ta plate by spot welding strips of Ta wire with 99.95% purity across the sample. This plate



was attached to the copper sample holder which was then attached to the cold finger of a helium cryocooler mounted in the CL's primary ultrahigh vacuum chamber. The sample faced a quartz viewing window with the electron gun at an angle of 30° with respect to the plane of the crystal. The sample holder temperature was maintained at 36 K using a Leybold CoolPower 4.2 CGM liquid helium circulation cryocooler to control the temperature of the sample holder and sample inside the main chamber.

A Kimball Physics EMG-12 electron gun with a barium oxide cathode and a thoriated tungsten filament was operated between 0.50 and 20.0 keV. For this experiment, the electron gun was operated at 12 keV with a beam current of 10 μA , as verified with a Keithley 6458 picoammeter. The photons emitted from the cathodoluminescence relaxation process were focused into the slit of a Spex 500 M monochromator. The photon signal was then detected with an EMI C31034 photomultiplier tube in a Products For Research, Inc. cooled housing that was operated at $-1200\,\mathrm{V}$. The resolution of the CL system was approximately 0.05 nm over the wavelength range of 200–800 nm that was measured in these experiments. The spectra were measured at 36 K in order to increase luminescence and improve the signal to noise ratio.

3 Results and discussion

3.1 Occupied and unoccupied band structure results The measured photoemission intensites are plotted in Fig. 1 for both the occupied (a) and unoccupied (b) states, aligned to the Fermi energy. The red lines in Fig. 1 are pure Gaussian peaks with maximums placed at inflection points on the slopes of the lines in the ultraviolet photoemission (a) and inverse photoemission (b) spectra for determination of the band gap measurement. Although these experimental

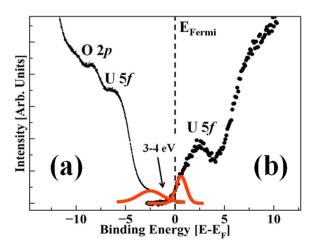


Figure 1 The experimental spectra for the (a) ultraviolet photoemission (occupied) and (b) inverse photoemission (unoccupied) states are plotted at normal incidence. Binding energies are referenced to the Fermi level as $E-E_{\rm F}$. The difference in the red Gaussian peaks' maxima, placed at inflection points along the spectra, were used to measure the band gap.

results are examining the electronic structure of a particular $U_x Th_{1-x} O_2$ solid solution (x = 0.22), at least three previous studies of the isomorphism moving from ThO₂ to UO₂ have been studied using X-ray diffraction [23, 42, 43] and extended X-ray absortion fine structure [43]. These studies concluded that structurally, the solid solutions U_xTh_{1-x}O₂ follow Vegard's law, with slight deviances in some cases (e.g., Ref. [42]) falling within the error of their experiments. Thus, while specific theoretical electronic calculations for our particular alloyed material do not exist, (aside from structural and thermodynamic calculations as in Ref. [44]), by studying the existing experimental and theoretical results for purely ThO2 and UO2 materials we may draw electronic conclusions concerning the solid solution of U_{0.22}Th_{0.78}O₂, assuming a "well-behaved" sample that follows Vegard's law.

In Table 1, experimental and theoretical results are listed for the band gap and weighted density of states (DOS) for the various electronic features of the actinide 5f and oxygen 2p concerning ThO2 and UO2 from the literature. These electronic properties are listed in units of eV. Although positive values are provided for the band gaps and DOS bandwidths, these are referenced with respect to the Fermi level $E_{\rm F}$ and provide information of the occupied DOS (not unoccupied). Most bandwidths provided for the 5f and 2p DOS are extracted from the data plots in the given reference, so should be considered as at least ± 1 eV. Under the source type heading, either the experimental technique(s) are provided such as X-ray photoemission (XPS), ultraviolet photoemission (UPS), inverse photoemission (IPES), resonant photoemission (RPES), and X-ray absorption near edge structure (XANES) or the theoretical approach is indicated, such as molecular orbital (MO) theory or DFT calculation with the provided exchange-correlation functions used (e.g., GGA-PBE).

From Ref. [54], molecular orbital calculations were made using the self-consistent relativistic variation method on clusters of $\rm UO_8^{12-}$ with U–O distance 2.37 Å (the model is essentially a U atom surrounded by a simple cubic structure of O atoms). From these calculations for pure $\rm UO_2$, the U $\it 5f$ band is narrow and localized strongly near the Fermi edge, while the O $\it 2p$ is more broadly found between 3.97 and 6.72 eV below the Fermi edge with strong O $\it 2p_{3/2}$ signature at 5.69 eV.

The UPS and IPES spectra are plotted in Fig. 1, with the occupied (UPS) and unoccupied (IPES) 5f states labeled. If the UO₂ calculations were blindly applied to the solid solution measurements, then the experimental results plotted in Fig. 1 would appear to be missing the U 5f weighted density of states (DOS) as there is a gap between the Fermi edge and the first rising edge of the data. The calculations give insight into the approximate energies and order of the Th 6d, U 5f, and O 2p states. However, at least two considerations need to be made: (i) these are molecular orbital calculations and thus ignore the solid state intricacies that would be appropriate to studying a large single crystal;

actinide oxide reference actinide 5f oxygen 2p gap source type year ThO_2 6-7 5.0 - 12.5UPS/IPES 2014 [38] 0.0 - 3.02.0 - 8.0**XANES** 2014 [38] 0.0 - 4.0B3LYP 6.9 0.0 - 3.02013 [45] 4.7 0.0 - 3.00.0 - 4.0LDA + U2013 [45] 4.5 LDA 2013 [45] 4.43 **GGA** 2011 [46] 4.637 0.0 - 3.790.0 - 3.79**GGA** 2010 [47] 0.0 - 5.0GGA-92 4.82 2005 [48] 2.0 - 7.0**RPES** [49] 5.0 1989 5.0 0.0 - 5.0**LMTO** 1989 [49] 6.0 ??? ??? ??? [50] 1965 $U_{0.22}Th_{0.78}O_2$ UPS/IPES 3-43.0 - 7.06.0 - 11.02015 this study UO_2 2.0 0.0 - 2.02013 2.0 - 6.0LDA + U[45] 5.8 0.0 - 1.61.8 - 5.8**GGA-PBE** 2010 [51] 1987 0.0 - 2.03.0 - 8.0**RPES** [52]

3.5 - 8.0

Table 1 Computational and experimental measurements of ThO₂ and UO₂ band gaps.

0.0 - 3.5

and (ii) the UO_2 calculations ignore the existing ThO_2 matrix in which the U atoms exist.

 5.0 ± 0.4

The O 2p weighted DOS is at approximately 8.5 eV and the U 5f weighted DOS at approximately 2.5 eV below the Fermi level. This is notable as the appearance of strong U 5f character indicates the available valence states due to the U dopant are active within the ThO₂ matrix, although there is still an appreciable gap between the U 5f occupied and unoccupied states when compared to pure UO₂. Nevertheless, with the availability of the U 5f states, it is expected that the material may be electronically tuned if the oxidation state of the uranium dopant could be controlled during the hydrothermal synthesis. Similarly, the unoccupied character as probed by IPES is primarily of U 5f character, although U/Th 6d states are expected but not clearly evident in this case. The unoccupied structure begins at approximately 1.1 eV above the Fermi level, although as with the occupied structure, significant band tailing is evident and extends to approximately 0.1 eV below the Fermi level. From the molecular orbital diagrams of Teterin et al. on pure ThO₂ and UO₂ [54, 55] and the previous experimental of single crystal ThO₂ [38], the assignment of the U 5f states in the valence and conduction band can be made and is responsible for the smaller band gap than pure ThO₂ in this case.

We cannot exclude that a large number of defects and/or impurities, known to exist at such oxides surfaces in great abundance, contribute to significant band tailing, obscuring the actinide 6d/7s valence bands at the valence band maximum and the vertical binding energy of the unoccupied 5f/6d states that start at $1-2 \, \text{eV}$ above the Fermi level [38, 45]. An exact value for the band gap cannot be determined but is in the region $3-4 \, \text{eV}$. This result is consistent with prior experimental

measurements and theoretical calculations of UO_2 and ThO_2 as it lays between their reported 2–3 [51, 56, 57] and 6–7 eV [38, 45–47, 49, 50, 58, 59] band gaps, respectively.

1980

[53]

XPS/IPES

3.2 Analysis of solid solution and Vegard's law Previously, structural measurements [36] indicated that U was incorporated into the ThO₂ following Vegard's Law, allowing for lattice constant interpolation. Similarly, Vegard's Law can be applied [60] to determine an interpolative scheme as

$$E_{g}(x) = xE_{g,UO2} + (1 - x)E_{g,ThO2} - bx(1 - x),$$
 (1)

where E_g is the band gap energy of $U_x Th_{1-x}O_2$, $E_{g,ThO2}$ is the band gap of ThO₂, $E_{g,UO2}$ is the band gap of UO₂, and b is the bowing parameter for $U_x Th_{1-x}O_2$. Using this research's measured band gap and information found in the literature for pure ThO₂ and UO₂ [38, 45–47, 49–51, 56–59], the band bowing parameter b is determined with and without including theoretical calculations. Including all references, the band bowing term is $6.0 \pm 3.8 \, \text{eV}$ with estimates of the ThO₂ and UO₂ band gaps at 5.3 and 2.0 eV (± 0.2), respectively. Considering only the experimental data, the bowing term is 8.9 ± 3.1 eV with estimates of the ThO₂ and UO_2 band gaps at 5.8 and 2.2 eV (± 0.2), respectively, see Fig. 2. The larger difference in the ThO₂ band gap estimate may be attributed to the scattering of the experimental data. In all cases, experimental results are highly dependent on the material quality and type. Band gap information for fractional content x is lacking in the literature, consequently further research on similar alloys needs to be compiled in order to refine this first estimate of the band bowing term.



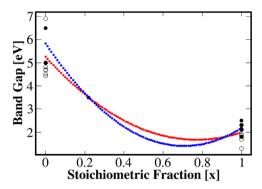


Figure 2 Theoretical values for ThO₂ (x=0) and UO₂ (x=1) band gap are plotted in open circles and experimental values as closed circles. The value at 0.22 is from this research, other values as referenced in text. Red dashed line is band gap from Eq. (1) accounting for all data; blue dashed line is only experimentally weighted.

While the band gap has been determined to be between 3 and 4 eV, a smaller functional gap due to the defects and impurities may be found through an optical technique such as photoluminescence or cathodoluminescence spectroscopy.

3.3 Cathodoluminscence results and analysis

For $U_{0.22}Th_{0.78}O_2$, the observed violet luminescence produced the spectrum in Fig. 3. The major peak of luminescence spans the region between 250 and 390 nm (3.18–4.96 eV) with a maximum at 303 nm (4.09 eV). The luminescence corresponds to the measured 3–4 eV band gap obtained from the combined UPS and IPES measurements. The dominant luminescence from the *f*-system crystals is assumed to be from the relaxation of an electron from the unoccupied U 5*f* state to the U 5*f* state within the valence band, and thus should frequently exceed the ground state band gap considerably. This transition is

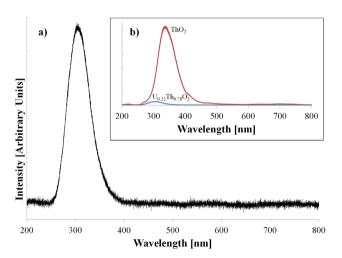


Figure 3 (a) Cathodoluminescence spectrum of $U_{0.22}Th_{0.78}O_2$ at 36 K. (b) Comparison of the cathodoluminescence intensities to display the differences between pure ThO₂ and $U_{0.22}Th_{0.78}O_2$.

spin-forbidden and explains the low intensity of luminescence. As a comparison, under the same conditions of excitation, a single crystal of ThO_2 has 40 times the luminescence because the photon that is emitted comes from a spin-allowed or quadruple Th 6d/5f to O 2p transition [38].

4 Conclusions Single crystals of $U_{0.22}Th_{0.78}O_2$ have been investigated to characterize the valence and conduction band structure in the vicinity of the band gap. While pure ThO_2 has been shown to have partial 5f occupation [38], the addition of U into the ThO_2 matrix has resulted in measurable 5f character near the top of the valence band and splitting across the gap to the bottom of the conduction band, resulting in a reduction of the ThO_2 band gap from 6 to 7 eV to 3–4 eV.

Since the Fermi level does not lie in the center of the forbidden gap but closer to the conduction band minimum, these crystals are n-type. This result is consistent with previous studies on the band structure of ThO₂ [38]. Interestingly, this is not the case for polycrystalline samples of pure UO2, which have been measured as p-type at room temperature, but becoming n-type at elevated temperatures $(\sim 1375 \text{ K})$. Of course, the UO₂ result is highly dependent on sample type and quality (e.g., polycrystalline, single crystal, glass) and that is the expected case here [16]. Considering the significant band tailing observed in the photoemission results and the broad spectral lines of the cathodoluminescence, it is expected that impurities and defects are largely responsible for the observed n-type behavior. Considering that the single crystals have been synthesized through a rapid growth process, the presence of structural defects is not surprising and defects have been noted in previous research [38]. We are assuming the same types of defects as in the case of the thorium dioxide single crystals because the two crystal systems were synthesized in very similar manners.

The incorporation of uranium into the thorium dioxide crystal matrix introduces U 5f states to the top of the valence band and bottom of the conduction band. The cathodoluminescence spectroscopy data aligns itself well with the data obtained from ultraviolet and inverse photoemission spectroscopy and the band gaps from each correspond with one another. The major luminescence peak from the U_{0.22}Th_{0.78}O₂ single crystal is broad and can be accounted for by intrinsic defects or due to the amount of hybridization between the orbitals. The luminescence from the $U_{0.22}Th_{0.78}O_2$ single crystal is weak due to the U $5f^* \rightarrow$ U 5f transition which is believed to make up the majority of the character across the band gap [54, 55, 61]. However, due to the fact that the metals involve in this system are of such high Z in nature, the hybridization of the orbitals involved in the conduction band is significant. The luminescence emitted from this crystal system is greater than expected due to hybridization of the Th and U 6d, spin-allowed transition and Th and U 7p, quadrapole transition within the conduction band [38, 61]. With this progress in determining the fundamental properties of mixed actinide oxide materials, studies may now be considered where there is a methodical and consistent effort to manipulate the defect densities.

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